

Commissioning the CMS Pixel detector with cosmic ray data

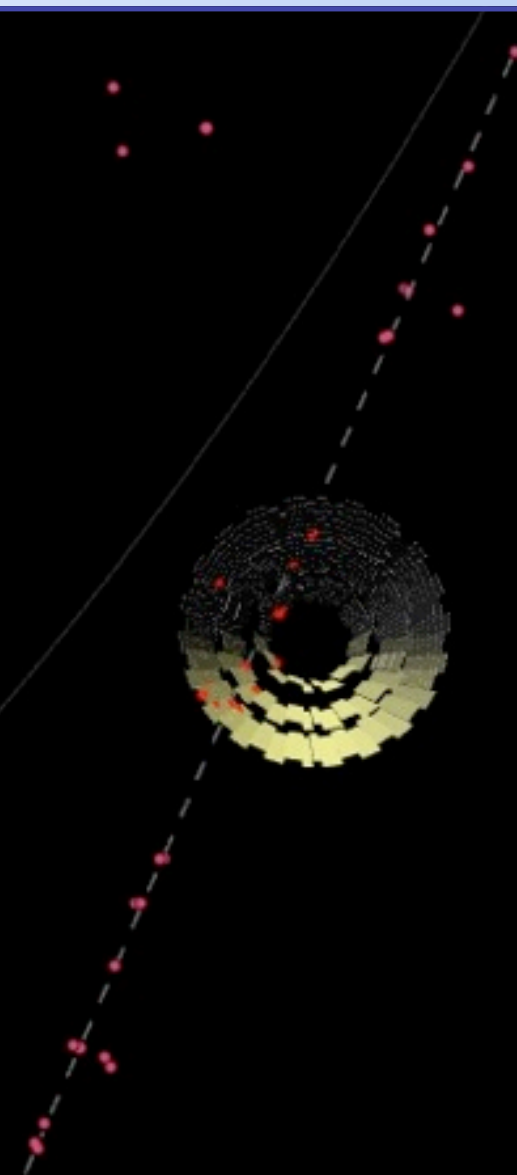
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On behalf of the CMS Pixel group

14th RD50 Workshop

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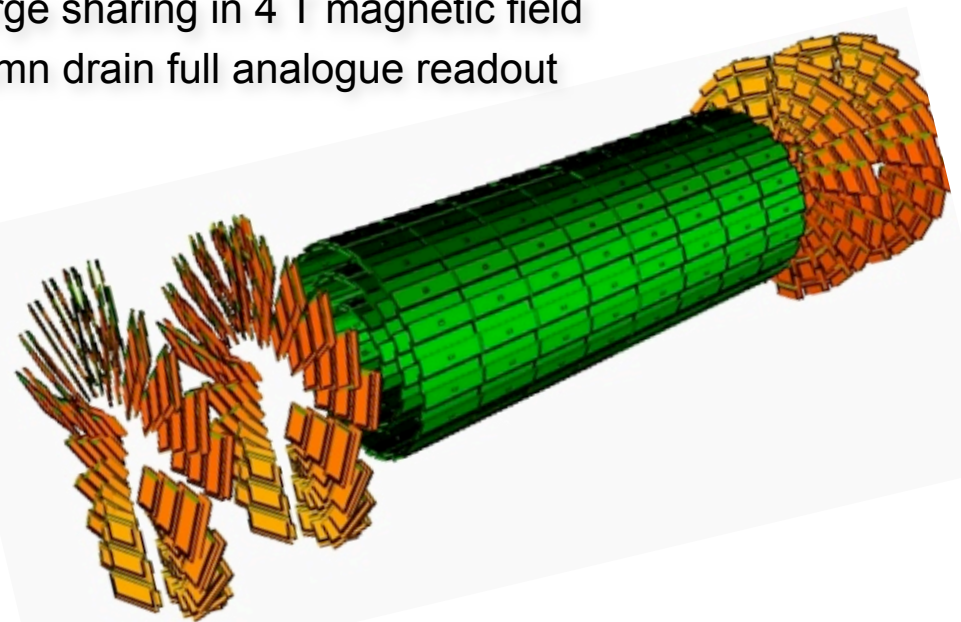
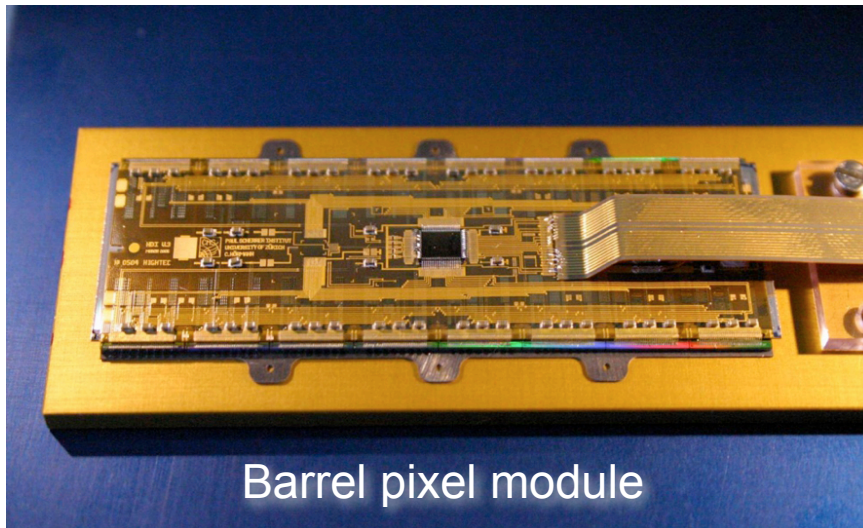


- **Detector layout and installation**
- **First results from cosmic ray data:**
 - ◆ Thresholds and charge collection
 - ◆ Lorentz angle and position resolution
- **Performance after irradiation from test-beam measurements:**
 - ◆ Charge collection and cluster multiplicity
 - ◆ Position resolution

Detector layout



- **Three barrel layers and two endcap disks at each barrel end**
 - ◆ Barrel layers at 4 cm, 7 cm, and 11 cm radius
 - ◆ ~700 modules made of 16 chips in barrel region (67k channels/module)
 - ◆ Endcap disks: 24 blades made of 7 sensors (4 or 3 per side)
 - ◆ About 67×10^6 channels in total, $L \sim 1$ m, $R \sim 30$ cm
- **Sensors and front-end electronics:**
 - ◆ “*n-in-n*” design with p-spray (CiS, barrel) and p-stop (Sintef, endcaps) isolation
 - ◆ $100(r\phi) \times 150(z)$ μm^2 pixel cell, charge sharing in 4 T magnetic field
 - ◆ PSI 0.25 μm CMOS chip with column drain full analogue readout



Detector installation

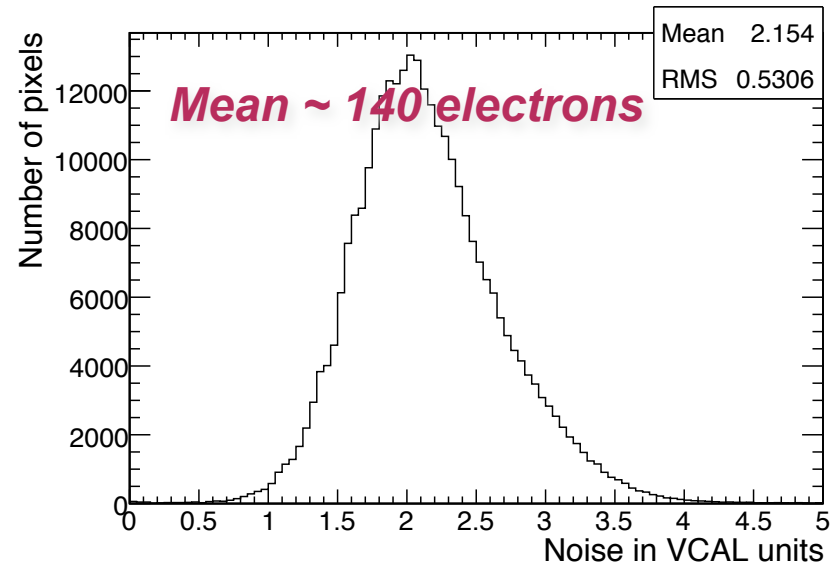
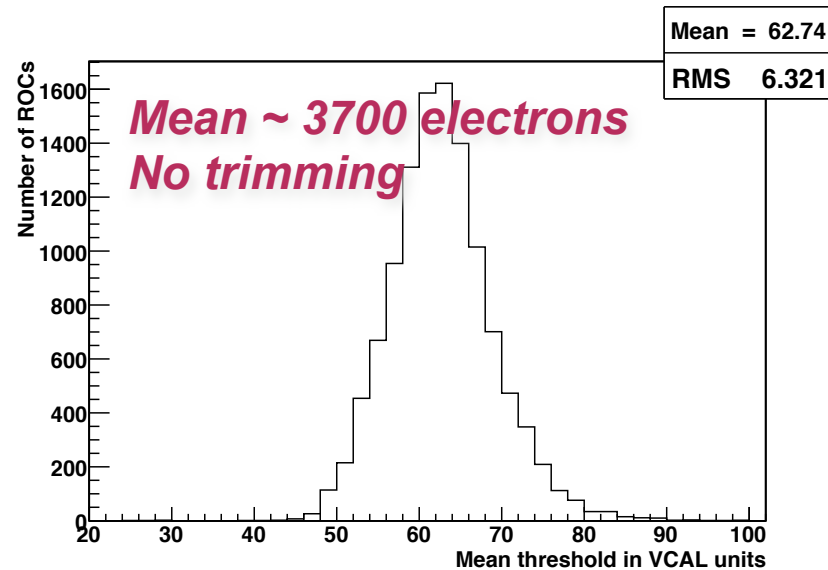


BPIX inserted on
July 2008

Z

Tracker bulkhead

Pixel thresholds & noise



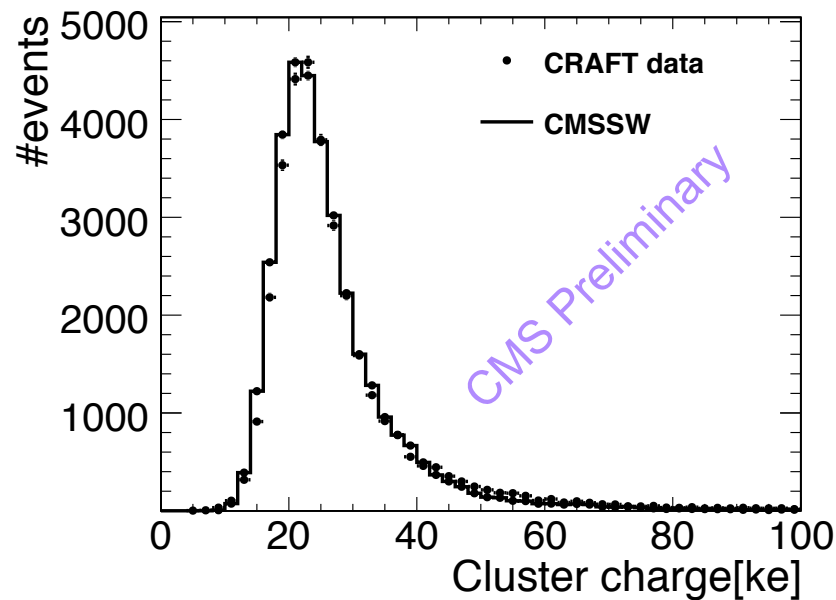
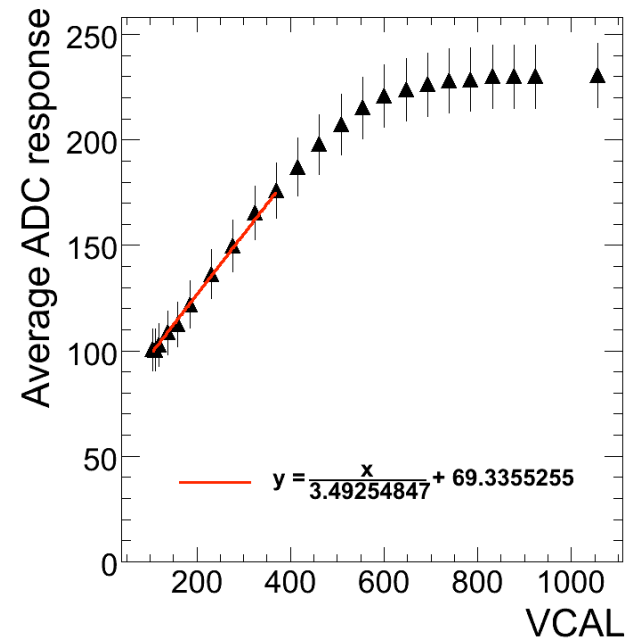
- Absolute readout threshold measured with pulser scans
 - ◆ Not enough time to perform fine trimming before cosmic data taking
 - ◆ In-time threshold due to time-walk effect ~5000 electrons
 - ◆ Front-end chip noise from threshold fluctuation ~140 electrons
 - Other sources of electronic noise (e.g. optical transceivers) ~300 electrons

Charge collection



Pixel charge calibrated with pulser signal:

- ◆ Converts ADC counts into electrons
- ◆ Low charge part fitted with straight line
- ◆ 1 VCAL unit ~ 65 electrons



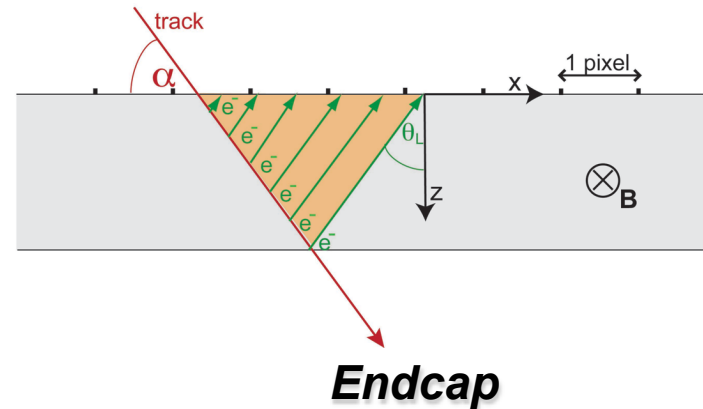
Cluster charge after calibration

- ◆ Only clusters with charge sharing
- ◆ Most probable value ~21'000 electrons
- ◆ In agreement with simulation within 5%

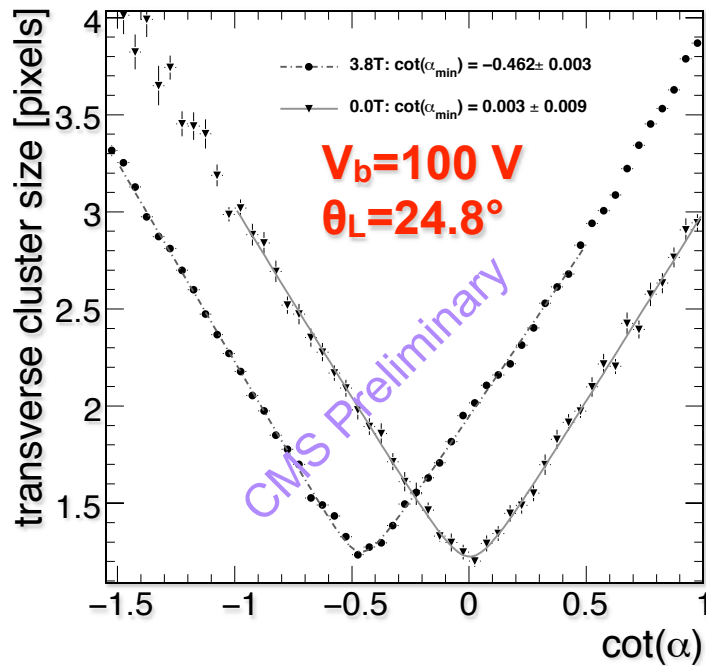
Lorentz angle



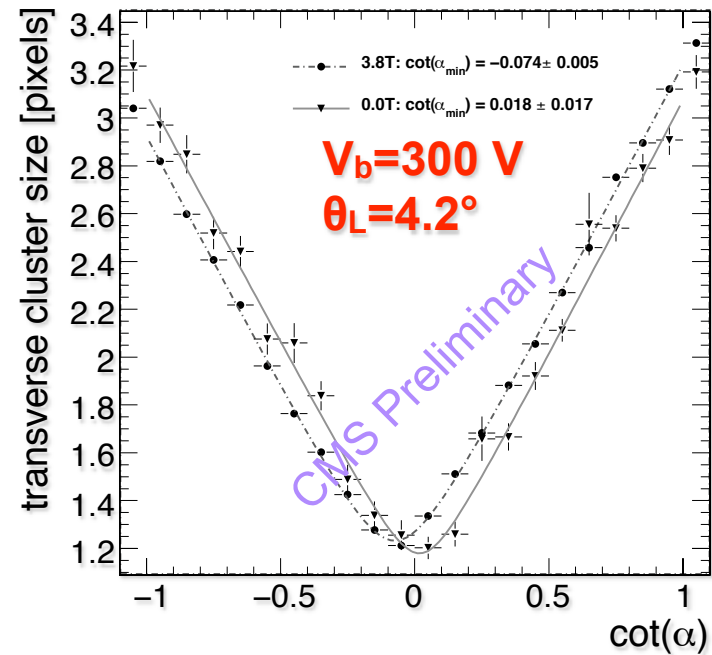
- Measured from the minimum of the cluster size vs. impact angle
- Bias=100V, 300V - Temp.=20°C
- Compatible with the expectations



Barrel



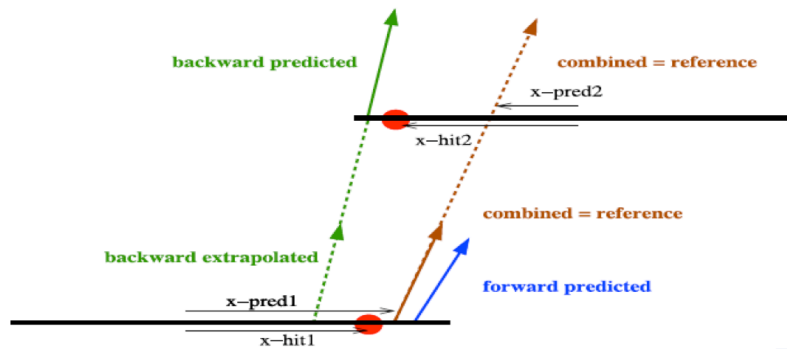
Endcap



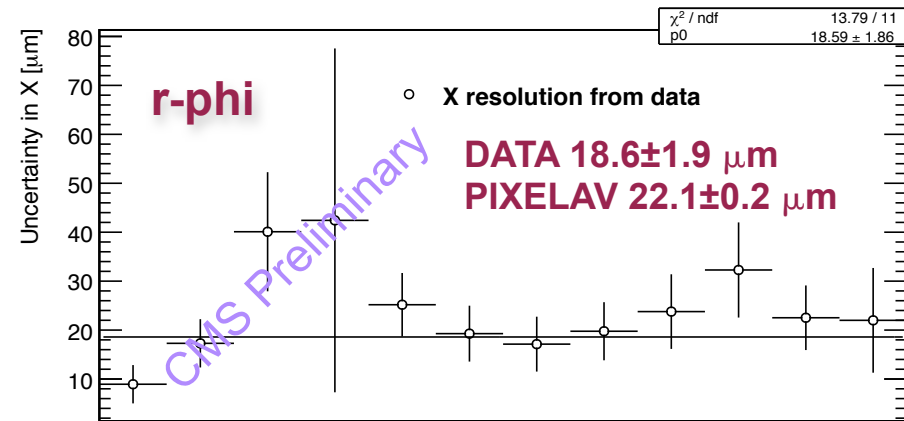
Position resolution



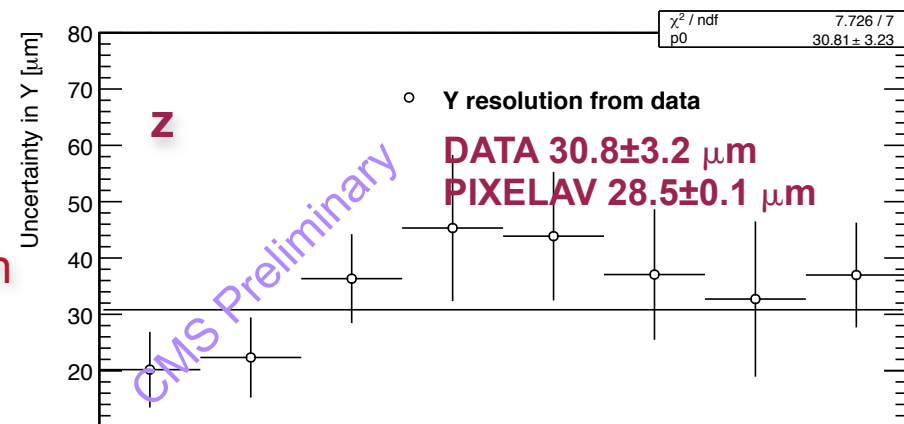
3.8T field, In-time threshold ~5000 electrons



- Position resolution measured from overlapping sensors in a given layer
- Less sensitive to misalignment and multiple scattering
- Measured values are compatible with the PIXELAV simulation



overlap measurement

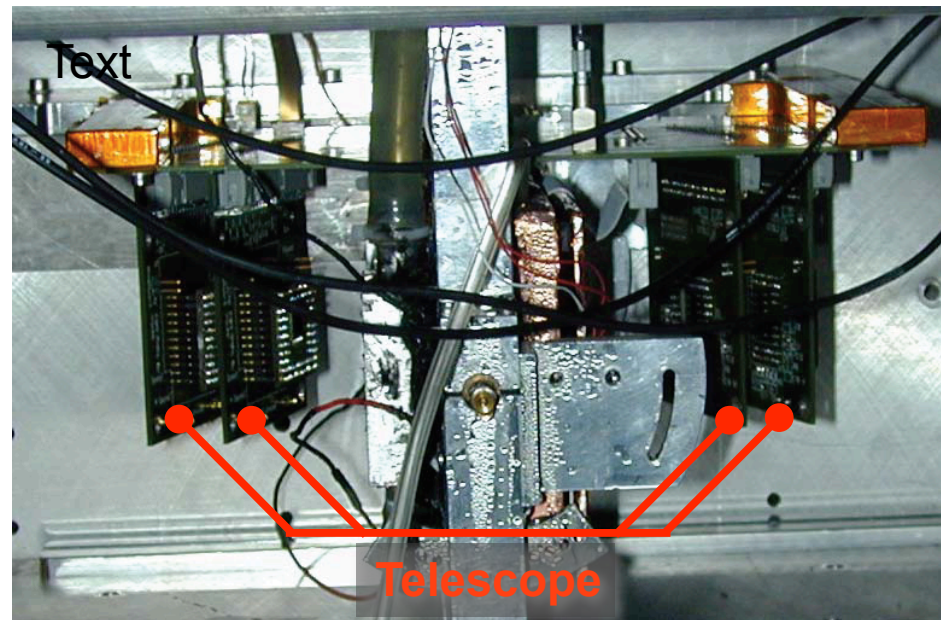
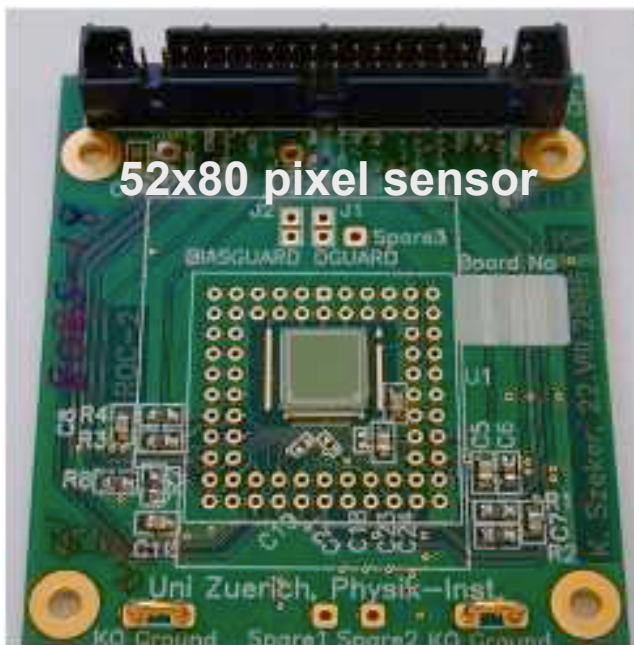


overlap measurement

Performance after irradiation



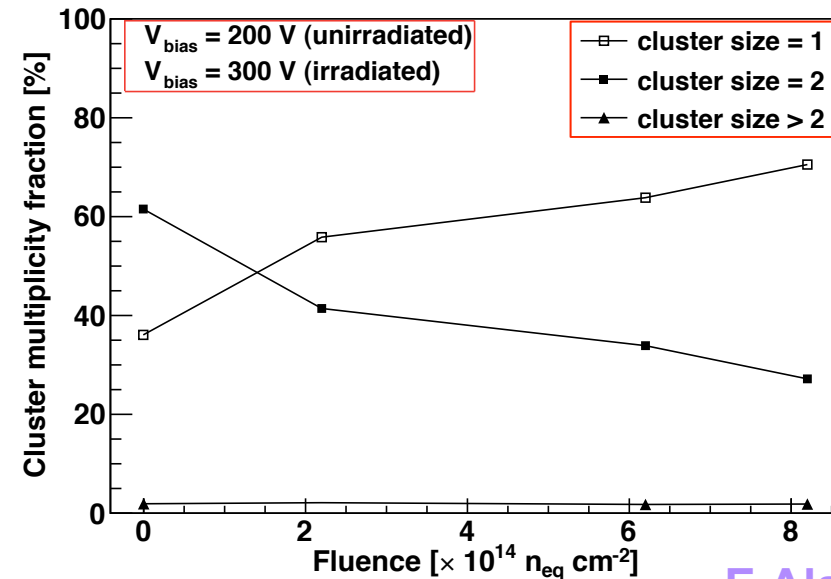
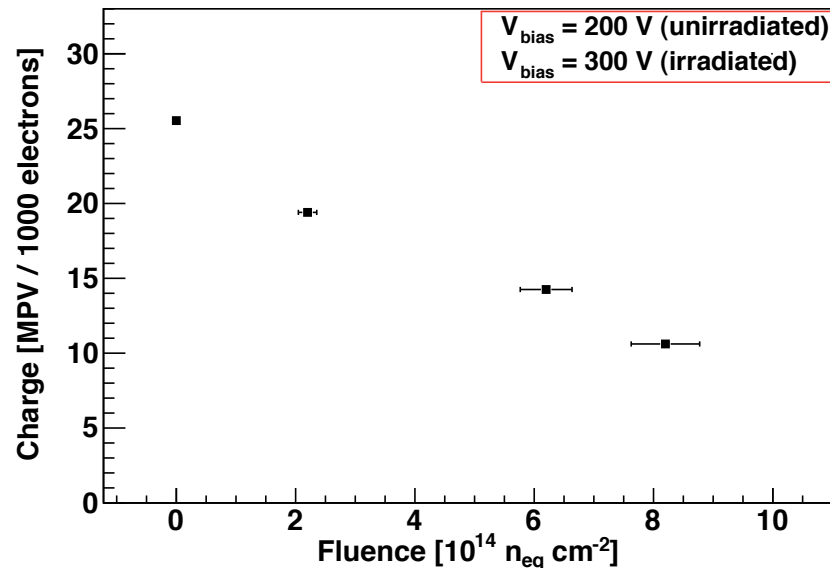
- Sensor performance measured at the CERN H2 beam line with 150 GeV pions
 - ◆ Fully pixel-based telescope with four planes.
 - ◆ Final sensor layout (p-spray, $100 \times 150 \mu\text{m}^2$) and front-end electronics
 - ◆ Setup installed in the H2 3T superconducting solenoid
 - ◆ Sensors irradiated up to $8 \times 10^{14} \text{ n/cm}^2$, standard annealing
- Fluence expected after first four years at 4 cm layer = $6 \times 10^{14} \text{ n/cm}^2$



Charge and cluster size



Straight tracks, 3T field, Readout threshold ~ 2850 electrons



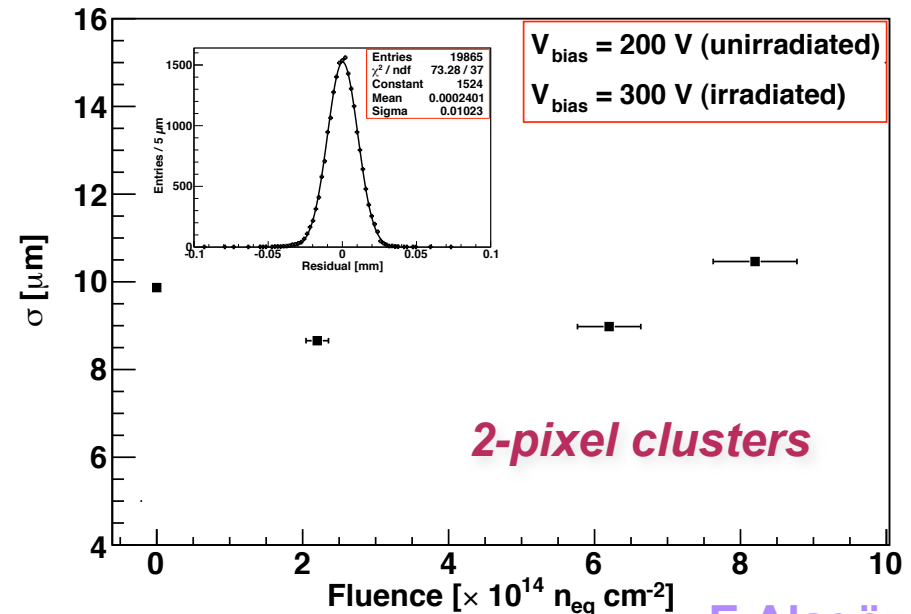
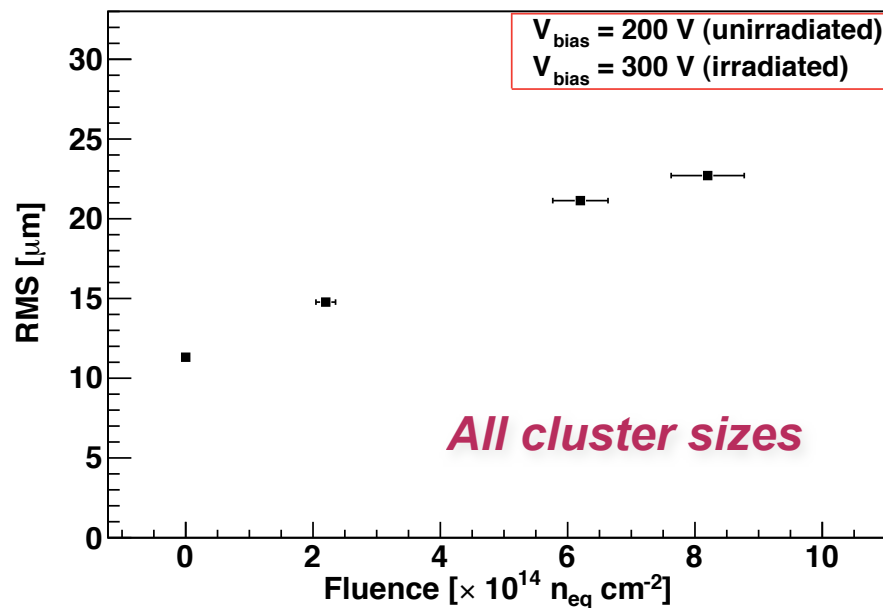
E.Alagöz

- Cluster charge at $6 \times 10^{14} n/cm^2$ about 50% of startup value
 - ◆ Expect decrease of hit detection efficiency
- Clusters of single pixels become dominant at $2 \times 10^{14} cm^2$
 - ◆ Expect degradation of position resolution due to reduced charge sharing

Position resolution



Straight tracks, 3T field, Readout threshold ~ 2850 electrons



E.Alagöz

- Position resolution degrades by almost a factor 2 at $\Phi_{eq}=6 \times 10^{14} n/cm^2$
 - ◆ Dominated by increase of single-pixel clusters
- Resolution of 2-pixel clusters almost flat vs. Φ_{eq}

- CMS pixel detector installed in summer 2008 has been tested with cosmic ray events
 - ◆ Charge collection behaves as expected
 - ◆ Lorentz angle in barrel section $\sim 25^\circ$ at (100V, 20°C, 3.8T). To be remeasured this year at 150V and 10°C
 - ◆ Position resolution is well described by PIXELAV simulation
- Performance after irradiation were measured at the H2 beam line with a 3T magnetic field, final sensor, final front-end chip
 - ◆ 10 ke⁻ cluster charge at $\Phi=8 \times 10^{14}$ n_{eq}/cm², 300V
 - ◆ Single pixel clusters become dominant around $\Phi=2 \times 10^{14}$ n_{eq}/cm²
 - ◆ RMS of residuals at $\Phi=8 \times 10^{14}$ n_{eq}/cm² is ~ 23 μm. Unirradiated ~ 12 μm.

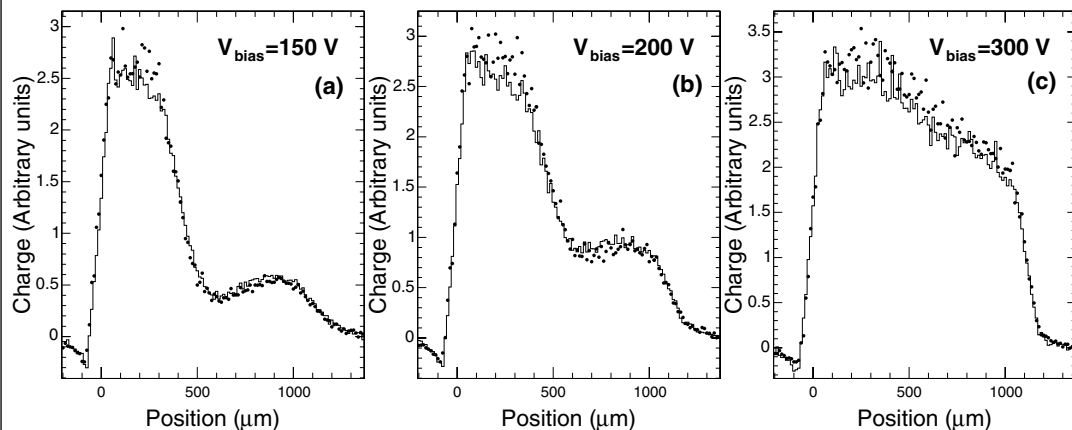
BACKUP

PIXELAV: a sensor simulation



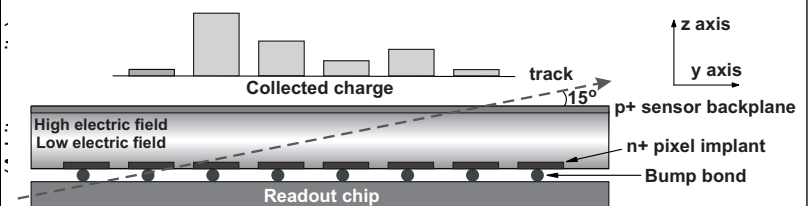
- In addition to the standard CMSSW full detector simulation a dedicated pixel sensor and front-end simulation was developed
- Electrostatic simulation based on TCAD plus charge creation, drift and signal induction based on custom program PIXELAV.
- Incorporates double-trap effective model of radiation damage. Describes cluster shapes from beam tests in a wide fluence range $\Phi_{eq}=(0.5-6)\times 10^{14}$ n/cm²
- The simulation is used to extract average cluster shapes, called *templates*

Sensor irradiation: $\Phi=6\times 10^{14}$ n/cm²



Full line: PIXELAV simulation
Full dots: test beam measurements

Grazing angle technique



V.Chiochia, M.Swartz et al.

Nucl.Instrum.Meth.A565:212-220,2006

Nucl.Instrum.Meth.A568:51-55,2006

IEEE Trans.Nucl.Sci.52:1067-1075,2005